

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Applicants:	Date: June 4, 2007
B. S. Beaman et al.	Group Art Unit: 2829
Serial No.: 10/145,661	Examiner: J. M. Hollington
Filed: May 14, 2002	Docket No.: YOR919990088US1
For: STRUCTURAL DESIGN AND PROCESSES TO CONTROL PROBE POSITION ACCURACY IN A WAFER TEST PROBE ASSEMBLY	

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

SUPPLEMENTAL RESPONSE TO OFFICE ACTION DATED MARCH 1, 2007

Sir:

In response to the Office Action dated March 1, 2007, please amend the above-identified application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 5 of this paper.